





#### Description

Current Limiting Module (CLM) is a chip type surface mountable device that can protect against both overcurrent and overcharging. It comprises a fuse element to ensure stable operation under normal electrical current and to cut off the current when overcurrent occurs. It also comprises a resistive heating element that could be used in combination with a voltage detecting means, such as IC and FET. When overvoltage is detected, the heating element is electrically excited to generate heat to blow the fuse element to achieve overvoltage protection.

#### Features

- Halogen-free
- Overcharging protection
- Overcurrent protection

#### Application

- Notebook
- · Cell phone
- Camera
- Ultrabook

 Surface mountable · Fast response time

- Tablet PC
- Automotive applications
- Printer

94

Security systems

Regulation

Halogen Free

#### Agency Approval and Environmental Compliance



#### **Electrical Specifications**

Dort Number	Irated Cells in	V <sub>max</sub> I <sub>bre</sub>	Ibreak	k Vop	Resistance		Agency Approval		
Part Number	(A)	series	(V <sub>DC</sub> )	(A)	(V)	R <sub>heater</sub> (Ω)	R <sub>fuse</sub> (mΩ)	c <b>W</b> us	TÜVRheinland
CLM1612P0415C	15	1	36	50	3.0 ~ 4.5	0.6 ~ 1.5	1.0 ~ 3.0	✓	~
CLM1612P0815C	15	2	36	50	5.0 ~ 9.0	2.2 ~ 3.3	1.0 ~ 3.0	✓	~
CLM1612P1215C	15	3	36	50	7.4 ~ 13.8	5.5 ~ 8.4	1.0 ~ 3.0	$\checkmark$	~
CLM1612P1415C	15	4	36	50	10.5 ~ 19.6	10.4 ~ 15.8	1.0 ~ 3.0	✓	~
CLM1612P2015C	15	5	36	50	14.4 ~ 23.5	17.9 ~ 29.1	1.0 ~ 3.0	~	~

Standard

IEC 61249-2-21:2003







#### **Electrical Characteristics**

Current Capacity	100% x I <sub>rated</sub> No Melting
Cut Time	200% x I <sub>rated</sub> < 1 min
Interrupting Current	5 x I <sub>rated</sub> , power on 5 ms, power off 995 ms, 10000 cycles No Melting

#### **Note on Electrical Specifications & Characteristics**

#### Vocabulary

Irated	= Current carrying capacity that is measured at 40°C thermal equilibrium condition.	
Ibreak	= The current that the fuse element is able to interrupt.	
V <sub>max</sub>	= The maximum voltage that can be cut off by fuse.	
Rheater	= The resistance of the heating element.	
R <sub>fuse</sub>	= The resistance of the fuse element.	
<b>Cells in series</b> = Number of battery cells connected in series in the circuit for CLM device to protect.		

- Value specified is determined by using the PWB with 2mm\*2oz copper traces, AWG18 covered wire, and 0.6mm glass epoxy PCB.
- Specifications are subject to change without notice.

### **A**WARNING

#### General

- Before and after mounted, the ultrasonic-cleaning or immersion-cleaning must not be done to CLM device. The flux on element would flow, and it would not be satisfied its specification when cleaning is done. In addition, a similar influence happens when the product comes in contact with cleaning-solution. These products after cleaning will not be guaranteed.
- Silicone-based oils, oils, solvents, gels, electrolytes, fuels, acids, and the like will adversely affect the properties of CLM devices, and shall not be used or applied.
- Please Do Not reuse the CLM device removed by the soldering process.
- CLM devices are secondary protection devices and are used solely for sporadic, accidental over-current or over-temperature error condition, and shall NOT be used if or when constant or repeated fault conditions (such fault conditions may be caused by, among others, incorrect pin-connection of a connector) or over-extensive trip events may occur.
- Operation over the maximum rating or other forms of improper use may cause failure, arcing, flame and/or other damage to the CLM devices.
- The performance of CLM devices will be adversely affected if they are improperly used under electronic, thermal and/or mechanical procedures and/or conditions non-conformant to those recommended by manufacturer.
- Customers shall be responsible for determining whether it is necessary to have back-up, failsafe and/or fool-proof protection to avoid or minimize damage that may result from extra-ordinary, irregular function or failure of CLM devices.





#### **Thermal Derating Characteristics**

Ambient Temperature (°C)	25	40	60
Recommend Rated Current (A)	18.0	16.0	13.5

#### **Cut Time by Heater Operation**

■ Various heater wattage at 25°C ambient temperature.



### 0.1 0.1 0.01 -10 25 85 Amblent Temperature (°C)

Constant heater wattage at various ambient temperature.

#### **Cut Time by Current Operation**

■ Various interrupting current at 25°C ambient temperature.



Constant 2x rated current at various ambient temperature.









### **Physical Dimensions (mm.)**



A	3.00 ± 0.2
В	4.00 ± 0.3
С	0.90 max
A1	$1.03 \pm 0.1$
A2	$0.96 \pm 0.1$
A3	$1.03 \pm 0.1$
A4	$1.44 \pm 0.1$
A5	$0.80 \pm 0.1$

B1	$1.26 \pm 0.1$
B2	$1.35 \pm 0.1$
B3	$0.67 \pm 0.1$
B4	$0.58 \pm 0.1$
B5	$0.50 \pm 0.1$

В

#### Part Number System



Ceramic Cover Rated Current (15A) Operation Voltage (4V) Company Symbol Device Size (L: 0.16", W: 0.12") Current Limiting Module

### **Environmental Specifications**

Operating/Storage Temperature	-10°C to +65 °C / <40°C,<60%RH
Hot Passivo Aging	100±5°C, 250 hours
Hot Passive Aging	No structural damage and functional failure
Humidity Aging	60°C±2°C, 90~95%R.H. 250 hours
Humany Aging	No structural damage and functional failure
Cold Dopping Aging	-20±3°C, 500 hours
Colu Passive Aging	No structural damage and functional failure
	MIL-STD-202 Method 107G
Thermal Shock	+125°C /-55°C, 100 times
	No structural damage and functional failure
Solvent Resistance	MIL-STD-202, Method 215
V/leve tieve	MIL-STD-883C, Method 2007.1, Condition A
VIDIATION	No structural damage and functional failure
Moisture Level Sensitivity	Level 1, J-STD-020C

#### Board and Solder Layout Recommend (mm)



Material	Glass Epoxy PCB
Base Thickness	0.6mm
Copper Thickness	0.07mm
Covered Wire	AWG18

A1	1.55 ± 0.1
A2	$0.90 \pm 0.1$
A3	$1.55 \pm 0.1$
A4	$1.60 \pm 0.1$
A5	$1.20 \pm 0.1$

B1	$1.20 \pm 0.1$
B2	$1.55 \pm 0.1$
B3	$2.40 \pm 0.1$

### Part Marking System







#### **Soldering Parameters**



Ť	ime 🚞
Average Ramp-Up Rate (Ts <sub>max</sub> to T <sub>P</sub> )	3°C/second max.
Preheat	
-Temperature Min (Ts <sub>min</sub> )	150°C
-Temperature Max (Ts <sub>max</sub> )	200°C
-Time (Ts <sub>min</sub> to Ts <sub>max</sub> )	60-180 seconds
Time maintained above:	
-Temperature (TL)	217°C
-Time (t∟)	60-150 seconds
Peak Temperature (T <sub>P</sub> )	260°C
Time within 5°C of actual Peak	
Temperature (t <sub>P</sub> )	20-40 seconds
Ramp-Down Rate	6°C /second max.
Time 25°C to Peak Temperature	5 minutes max.

#### Tape & Reel Specification (mm.)

Devices are packaged per EIA481 and EIA-2 standard



 $12.0 \pm 0.30$ 

5.50 ± 0.05

 $1.75 \pm 0.10$ 

 $1.55 \pm 0.05$ 

 $1.50 \pm 0.10$ 

 $4.00 \pm 0.10$ 

8.00 ± 0.10

 $2.00 \pm 0.10$ 

3.32 ± 0.10

 $4.32 \pm 0.10$ 

 $0.23 \pm 0.05$ 

 $1.3 \pm 0.10$ 

Tape & Reel Quantity

5000

W

F

E1

 $\mathbf{D}_0$ D1

P<sub>0</sub>

P<sub>1</sub>

P<sub>2</sub>

A<sub>0</sub>

B<sub>0</sub>

Т

K<sub>0</sub>

Н	$16.5 \pm 0.1$
W	$12.5 \pm 1.5$
D	Ø62.5 ± 0.5
С	Ø330 ± 1.0

### **Packaging Quantity**

Part Number CLM1612PXX15C

Note 1:	The temperature shown above is the top-side surface temperature of the device.
Note 2:	If the soldering temperature profile deviates from the recommended profile, devices

may not meet the performance requirements

0°C ~35°C,  $\leq$  70%RH 3 months after shipment

<b>D</b>
POLYTROMCS TECHNOLOGY COR
EGO/TS 10949, AMD EGO 14001
FILE MUMBER A6727 AND A1087

Storage Condition